



Test Report No.: NK-14-R-054

FCC and IC Certification

Nemko Korea Co., Ltd.

155 & 159, Osan-Ro, Mohyeon-Myeon, Cheoin-Gu, Yongin-Si, Gyeonggi-Do, 449-852 KOREA, REPUBLIC OF

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FCC and IC EVALUATION REPORT FOR CERTIFICATION

Applicant :

Samsung Electronics Co., Ltd.
129,samsung-ro, Yeongtong-gu, Suwon-si,
Gyeonggi-do, Korea 443-742
Attn. : Mr. Jaywoo, Lee

Dates of Issue : July 14, 2014
Test Report No. : NK-14-R-054
Test Site : Nemko Korea Co., Ltd.

FCC ID
IC

A3LBN8109939A
649E-BN8109939A

Brand Name

SAMSUNG

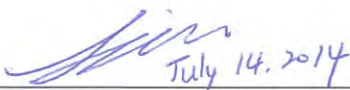
Contact Person

Samsung Electronics Co., Ltd.
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Mr. Jaywoo, Lee
Telephone No. : +82-31-277-2569

Applied Standard: FCC 47 CFR Part 15C and IC 210 Issue 8
Classification: FCC Part 15 Spread Spectrum Transmitter (DSS)
EUT Type: Magic Presenter_Pointer

The device bearing the brand name and model specified above has been shown to comply with the applicable technical standards as indicated in the measurement report and was tested in accordance with the measurement procedures specified in ANSI C63.4-2003. The client should not use it to claim product endorsement by TAF or any government agencies. The test results in the report only apply to the tested sample.

I attest to the accuracy of data and all measurements reported herein were performed by me or were made under my supervision and are correct to the best of my knowledge and belief. I assume full responsibility for the completeness of these measurements and vouch for the qualifications of all persons taking them.


Tested By : Seung-young Shin
Engineer

 July 14, 2014
Reviewed By : Deokha Ryu
Manager & Chief Engineer

Samsung Electronics Co., Ltd.

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FCC ID : A3LBN8109939A / IC : 649E-BN8109939A

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1. SCOPE

Measurement and determination of electromagnetic emissions (EME) of radio frequency devices including intentional and/or unintentional radiators for compliance with the technical rules and regulations of the Federal Communications Commission under FCC part 15 and IC RSS-210 Issue 8.

Responsible Party :	Samsung Electronics Co., Ltd.
Contact Person :	Mr. Jaywoo, Lee
Manufacturer :	Samsung Electronics Co., Ltd. 129, samsung-ro, Yeongtong-gu, Suwon-si, Gyeonggi-do, Korea 443-742

- FCC ID: A3LBN8109939A
- IC: 649E-BN8109939A
- Model: BN81-09939A
- Brand Name: SAMSUNG
- EUT Type: Magic Presenter_Pointer
- Classification: 15C Intentional Radiator
- Applied Standard: FCC 47 CFR Part 15 subpart C and IC RSS-210 Issue 8
- Test Procedure(s): ANSI C63.4-2003 and FCC Public Notice DA 00-705 dated March 30, 2000 entitled "Filling and Measurement Guidelines for Frequency Hopping Spread Spectrum Systems"
- Dates of Test: February 12, 2014 ~ March 2, 2014
- Place of Tests: Nemko Korea Co., Ltd.

2. INTRODUCTION

2.1 Test facility

The measurement procedure described in American National Standard for Methods of Measurement of Radio-Noise Emissions from Low-Voltage Electrical and Electronic Equipment in the Range of 9 kHz to 40 GHz (ANSI C63.4-2003) was used in determining radiated and conducted emissions emanating from **Samsung Electronics Co., Ltd.** FCC ID : **A3LBN8109939A** and IC : **649E-BN8109939A**.

These measurement tests were conducted at **Nemko Korea Co., Ltd. EMC Laboratory**.

The site address is 155 & 159, Osan-Ro, Mohyeon-Myeon, Cheoin-Gu, Yongin-Si, Gyeonggi-Do, 449-852 KOREA, REPUBLIC OF.

The area of Nemko Korea Corporation Ltd. EMC Test Site is located in a mountain area at 80 kilo-meters (48 miles) southeast and Incheon International Airport (Incheon Airport), 30 kilometers (18 miles) south-southeast from central Seoul.

It is located in the valley surrounded by mountains in all directions where ambient radio signal conditions are quiet and a favorable area to measure the radio frequency interference on open field test site for the computing and ISM devices manufactures.

The detailed description of the measurement facility was found to be in compliance with the requirements of §2.948 according to ANSI C63.4 2003.



Nemko Korea Co., Ltd.
EMC Lab.

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Fig. 1. The map above shows the Seoul in Korea vicinity area.

The map also shows Nemko Korea Corporation Ltd. EMC Lab. and Incheon Airport.

2.2 Accreditation and listing

Accreditation type		Accreditation number
	FCC part 15/18 Filing site	Registration No. 97992
	CAB Accreditation for DOC	Designation No. KR0026
	KOLAS Accredited Lab. (Korea Laboratory Accreditation Scheme)	Registration No. 155
	Canada IC Registered site	Site No. 2040E
	VCCI registration site(RE/CE/Telecom CE)	Member No. 2118
	EMC CBTL	-
	KCC(RRL)Designated Lab.	Registration No. KR0026
	SASO registered Lab and Certification Body	Registration No. 2008-15

3. TEST CONDITIONS & EUT INFORMATION

3.1 Operation During Test

The Laptop was used to control the EUT to transmit the wanted TX channel by the Bluetool testing program which manufacturer supported. The Laptop and test jig were removed after controlling the EUT to transmit the wanted signal. The EUT was tested at the lowest channel, middle channel and the highest channel with the maximum output power in accordance with the manufacturer's specifications. The worst data were recorded in the report.

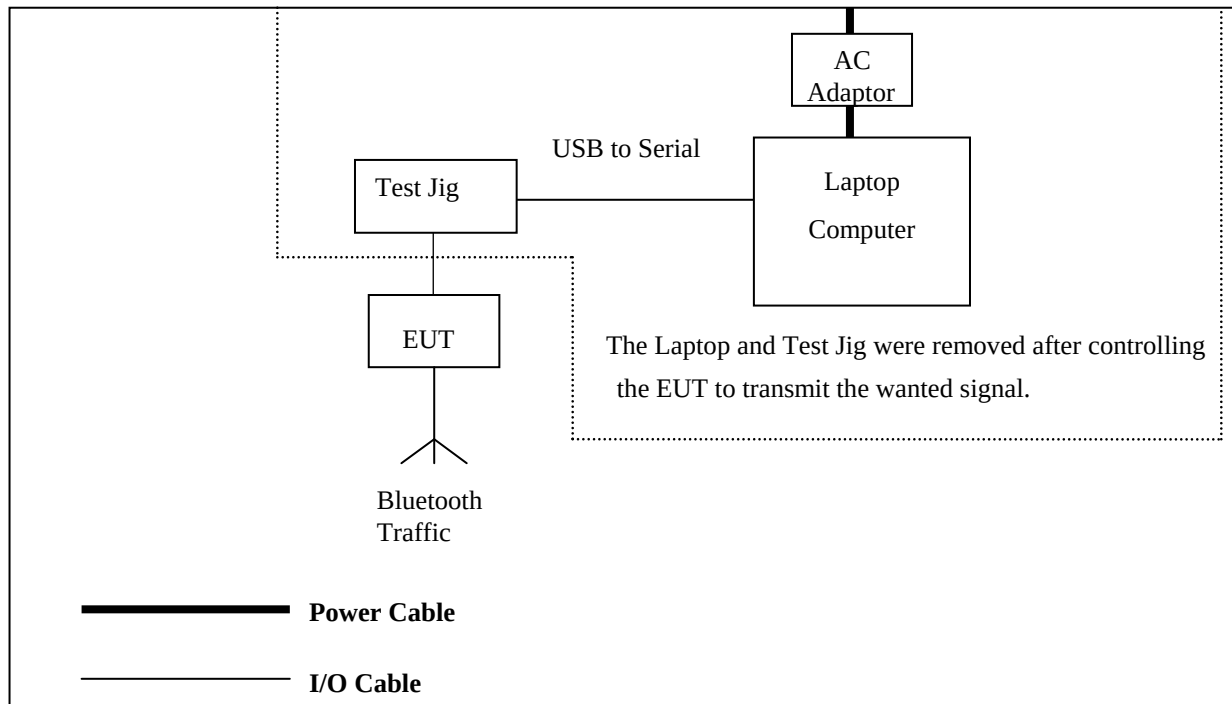
The EUT is programmed with the following setting during the testing:

Mode	Frequency Band	Power Setting Level
GFSK/ $\pi/4$ DQPSK/ 8DPSK	2402 MHz ~ 2480 MHz	Specify Power Table index

3.2 Support Equipment

Magic Presenter_ Pointer (EUT)	Samsung Electronics Co., Ltd. Model: BN81-09939A	FCC ID : A3LBN8109939A S/N: N/A
Laptop PC	HP Model : G62-355TU 1.5 m UART to USB shielded conversi on cable	FCC DOC S/N: CNF0489WDT
a.c.-d.c. Adaptor	Delta Electronics (Jiang su), Ltd. Model : PPP009D 1.5 m unshielded power cable	FCC DOC S/N: WBGSV0ACXZH162

3.3 Setup Drawing



3.4 EUT Information

The EUT is the **Samsung Magic Presenter_Pointer** FCC ID : **A3LBN8109939A** and IC : **649E-BN8109939A**.

This unit supports full qualified Bluetooth 3.0 with EDR standard system.

Specifications:

EUT Type	Magic Presenter_Pointer
Model Name	BN81-09939A
Brand Name	SAMSUNG
RF Frequency	2402 MHz ~ 2480 MHz
Peak Power Output (Conducted)	9.63 dBm
FCC Classification	FCC Part 15 Spread Spectrum Transmitter (DSS)
Method/System	Frequency Hopping Spread Spectrum (FHSS)
Channel Number	79
Modulation	GFSK, $\pi/4$ DQPSK, 8DPSK
Antenna Gain	1.99 dBi (Peak)
Power	3.0 Vdc (AAA type battery)
Size (W x H x D)	28.0 mm x 137.5 mm x 19.0 mm
Weight	33.8 g (without battery)

4. SUMMARY OF TEST RESULTS

The EUT has been tested according to the following specification:

Name of Test	FCC Paragraph No.	IC Paragraph No.	Result	Remark
Conducted Emission	15.207	RSS-GEN 7.2.4	N/A	Battery operation
Radiated Emission	15.209	RSS-210 A8.5	Complies	
20dB Bandwidth and Carrier Frequency Separation	15.247(a)(1)(iii)	RSS-210 A8.1	Complies	
Carrier Frequency Separation	15.247(a)(1)	RSS-210 A8.1(2)	Complies	
Transmitter Average Time of Occupancy	15.247(a)(1)(iii)	RSS-210 A8.1(4)	Complies	
Peak Power Output	15.247(b)(1)	RSS-210 A8.4(2)	Complies	
Conducted Spurious Emission	15.247(d)	RSS-210 A8.5	Complies	
Radiated Spurious Emission	15.247(d)	RSS-210 A8.5	Complies	
Number of Hopping channels	15.247(a)(1)(iii)	RSS-210 A8.1(4)	Complies	

5. RECOMMENDATION/CONCLUSION

The data collected shows that the **SAMSUNG Magic Presenter_Pointer** FCC ID : **A3LBN8109939A** and IC : **649E-BN8109939A** is in compliance with Part 15 Subpart C 15.247 of the FCC Rules and RSS-210 of the IC.

6. ANTENNA REQUIREMENTS

§15.203 of the FCC Rules part 15 Subpart C

: An intentional radiator shall be designed to ensure that no antenna other than that furnished by the responsible party shall be used with the device. The use of a permanently attached antenna or of an antenna that uses a unique coupling to the intentional radiator shall be considered sufficient to comply with the provisions of this section.

The antenna of the **SAMSUNG Magic Presenter_Pointer** FCC ID : **A3LBN8109939A** and IC : **649E-BN8109939A** is **permanently attached** and there are no provisions for connection to an external antenna. It complies with the requirement of §15.203.

7. DESCRIPTION OF TESTS

7.1 Conducted Emissions

The Line conducted emission test facility is located inside a 4 x 7 x 2.5 meter shielded enclosure. It is manufactured by EM engineering. The shielding effectiveness of the shielded room is in accordance with MIL-STD-285 or NSA 65-6. A 1 m x 1.5 m wooden table 0.8 m height is placed 0.4 m away from the vertical wall and 1.5 m away from the side of wall of the shielded room. Rohde & Schwarz (ESH3-Z5) and (ESH2-Z5) of the 50 ohm/50 μ H Line Impedance Stabilization Network (LISN) are bonded to the shielded room. The EUT is powered from the Rohde & Schwarz LISN (ESH3-Z5) and the support equipment is powered from the Rohde & Schwarz LISN (ESH2-Z5). Power to the LISNs are filtered by high-current high insertion loss Power line filters. The purpose of filter is to attenuate ambient signal interference and this filter is also bonded to shielded enclosure. All electrical cables are shielded by tinned copper zipper tubing with inner diameter of 1 / 2 ". If DC power device, power will be derived from the source power supply it normally will be powered from and this supply lines will be connected to the LISNs, All interconnecting cables more than 1 meter were shortened by non inductive bundling (serpentine fashion) to a 1 meter length. Sufficient time for EUT, support equipment, and test equipment was allowed in order for them to warm up to their normal operating condition. The RF output of the LISN was connected to the spectrum analyzer to determine the frequency producing the maximum EME from the EUT. The spectrum was scanned from 150 kHz to 30 MHz with 200 msec sweep time. The frequency producing the maximum level was re-examined using the EMI test receiver. (Rohde & Schwarz ESCS30). The detector functions were set to CISPR quasi-peak mode & average mode. The bandwidth of receiver was set to 9 kHz. The EUT, support equipment, and interconnecting cables were arranged and manipulated to maximize each EME emission. Each emission was maximized by; switching power lines; varying the mode of operation or resolution; clock or data exchange speed; scrolling H pattern to the EUT and of support equipment, and powering the monitor from the floor mounted outlet box and computer aux AC outlet, if applicable; whichever determined the worst case emission. Each EME reported was calibrated using the R&S signal generator.

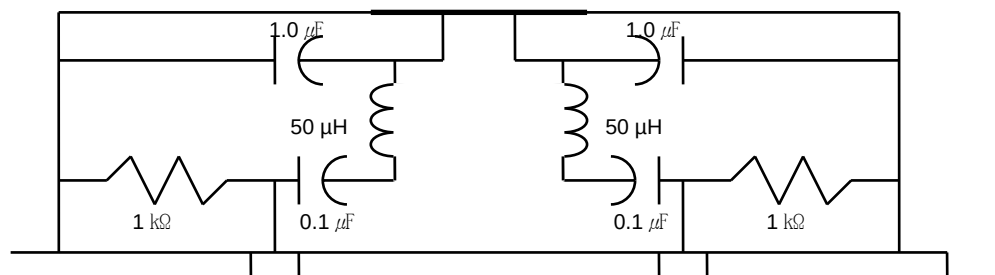


Fig. 2. LISN Schematic Diagram

7.2 Radiated Emissions

Test Procedure

The measurement was performed at the test site that is specified in accordance with ANSI C63.4-2003.

The spurious emission was scanned from 9 kHz to 30 MHz using Loop Antenna and 30 to 1000 MHz using Bi-conical log Antenna. Above 1 GHz, Horn antenna was used.

The test equipment was placed on turntable with 0.8 m above ground. Sufficient time for the EUT, support equipment, and test equipment was allowed in order for them to warm up to their normal operating condition. The EUT, cable, wire arrangement and mode of operation that has the highest amplitude relative to the limit was selected. Then, the turn table was rotated from 0° to 360° and an antenna mast was moved from 1 m to 4 m height to maximize the suspected highest amplitude signal. The receiver bandwidth was set to 120 kHz for measurements below 1 GHz. For the measurement above 1 GHz, Radiated Peak measurements were taken with RBW set to 1 MHz and VBW was set to 1 MHz with peak detector. Average measurements were taken with RBW 1 MHz and VBW was set to 1 kHz(> 1/τ Hz where τ is pulse width on second) with peak detector.

Radiated emission limits

Frequency (MHz)	Field strength (microvolts/meter)	Measurement distance (meters)
0.009–0.490	2400/F(kHz)	300
0.490–1.705	24000/F(kHz)	30
1.705–30.0	30	30
30–88	100	3
88–216	150	3
216–960	200	3
Above 960	500	3

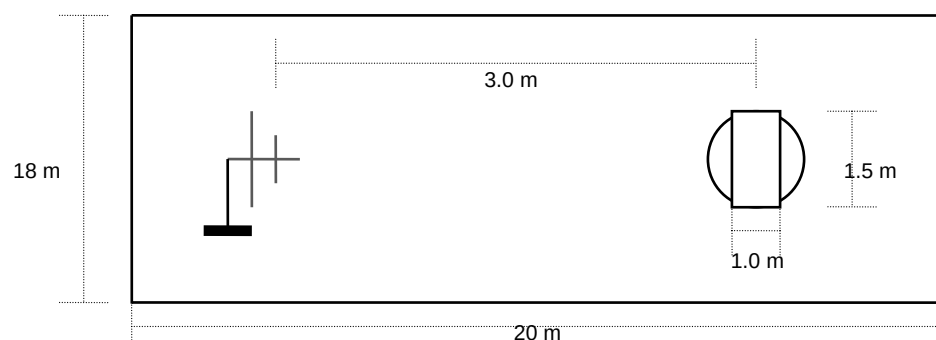
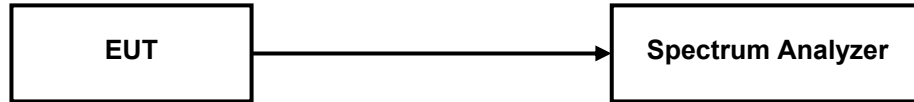


Fig. 3. Dimensions of Outdoor Test Site

7.3 20 dB Bandwidth and Carrier Frequency Separation

Test Setup



Test Procedure

The transmitter is set to the Low, Middle, High channels is connected to the spectrum analyzer.

Span = approximately 2 to 3 times the 20 dB bandwidth, centered on a hopping channel

RBW $\geq$ 1% of the 20 dB bandwidth

VBW $\geq$ RBW

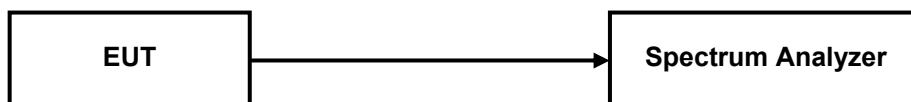
Sweep = auto

Detector function = peak

Trace = max hold

7.4 Transmitter Average Time of Occupancy

Test Setup



Test Procedure

The transmitter output is connected to a spectrum analyzer. The following spectrum analyzer setting is used.

Span = Zero span, centered on a hopping channel

RBW = 1 MHz, VBW $\geq$ RBW

Sweep = as necessary to capture the entire dwell time per hopping channel

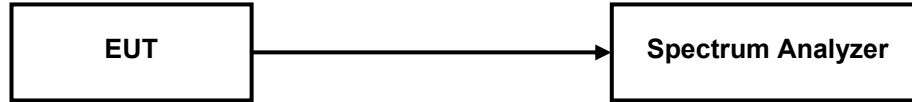
Detector function = Peak

Trace = Single sweep

Use the marker-delta function to determine the width of pulse

7.5 Number of Hopping Channels

Test Setup



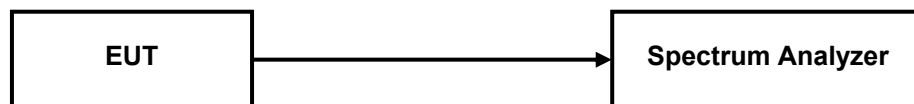
Test Procedure

The transmitter output is connected to a spectrum analyzer. The span is set to cover the entire authorized band, In either a single sweep or in multiple continuous sweeps. The RBW is set to 1 % of the span.

The spectrum analyzer is set to Max Hold.

7.6 Maximum Peak Output Power

Test Setup



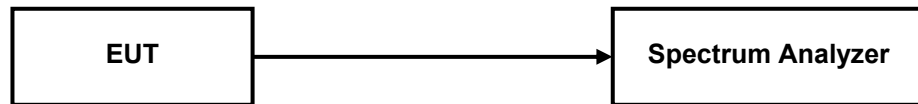
Test Procedure

The transmitter is set to the Low, Middle, High channels is connected to the spectrum analyzer. The RBW of spectrum analyzer is set to 3 MHz and VBW is set to the 3 MHz.

The sweep time is coupled.

7.7 Conducted Spurious Emission

Test Setup



Test Procedure

The transmitter is connected to the spectrum analyzer.

The RBW of spectrum analyzer is set to 100 kHz and VBW is set to the 300 kHz.

Measurements are made over the 30 MHz to 25 GHz range with the transmitter set to the Lowest, middle and highest channels.

8. TEST DATA

8.1 Radiated Emissions

FCC §15.209, IC RSS-210 A8.5

Frequency (MHz)	Reading (dBμV/m)	Pol* (H/V)	Antenna Heights (cm)	Turntable Angles (°)	AF+CL+Amp (dB)**	Result (dBμV/m)	Limit (dBμV/m)	Margin (dB)
173.17	56.36	V	130	178	-25.5	30.9	43.5	12.6
178.75	38.40	V	130	99	-25.2	29.5	43.5	14.0
269.49	53.26	V	100	348	-20.1	33.2	46.0	12.8
422.61	32.70	V	100	18	-15.1	35.0	46.0	11.0
490.80	52.56	V	100	4	-13.2	39.4	46.0	6.6
997.38	42.06	H	330	40	-5.5	36.6	54.0	17.4

Radiated Measurements at 3 meters

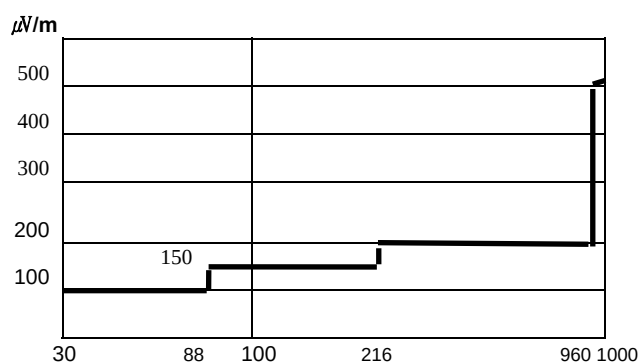


Fig. 4. Limits at 3 meters

Note(s)

1. All modes were measured and the worst-case emission was reported.

2 The radiated limits are shown on Figure 4.

Above 1GHz the limit is 500 μV /m.

3. *Pol. H = Horizontal V = Vertical

4. **AF + CL + Amp. = Antenna Factor + Cable Loss + Amplifier.

5. Measurements using CISPR quasi-peak mode below 1 GHz.

6. The radiated emissions testing were made by rotating the receive antenna with horizontal, Vertical polarization. The worst date was recorded.

TEST DATA

8.2 20 dB Modulated Bandwidth

FCC §15.247(a)(1)(iii), IC RSS-210 A8.1

Test Mode : Set to Lowest channel, Middle channel and Highest channel

Result:

Modulation Mode	Frequency(MHz)	Result(kHz)	Limit(kHz)
GFSK	2402	992	Non specified
GFSK	2441	944	Non specified
GFSK	2480	946	Non specified
$\pi/4$ DQPSK	2402	1276	Non specified
$\pi/4$ DQPSK	2441	1275	Non specified
$\pi/4$ DQPSK	2480	1276	Non specified
8DPSK	2402	1264	Non specified
8DPSK	2441	1262	Non specified
8DPSK	2480	1264	Non specified

PLOTS OF EMISSIONS

20 dB Bandwidth, Lowest Channel (2402 MHz, GFSK Mode)



20 dB Bandwidth, Middle Channel (2441 MHz, GFSK Mode)



PLOTS OF EMISSIONS

20 dB Bandwidth, Highest Channel (2480 MHz, GFSK Mode)



20 dB Bandwidth, Lowest Channel (2402 MHz, $\pi/4$ QPSK Mode)



PLOTS OF EMISSIONS

20 dB Bandwidth, Middle Channel (2441 MHz, $\pi/4$ DQPSK Mode)



20 dB Bandwidth, Highest Channel (2480 MHz, $\pi/4$ DQPSK Mode)



PLOTS OF EMISSIONS

20 dB Bandwidth, Lowest Channel (2402 MHz, 8DPSK Mode)



20 dB Bandwidth, Middle Channel (2441 MHz, 8DPSK Mode)



PLOTS OF EMISSIONS

20 dB Bandwidth, Highest Channel (2480 MHz, 8DPSK Mode)



TEST DATA

8.3 Carrier Frequency Separation

FCC §15.247(a)(1), IC RSS-210 A8.1(2)

Test Mode : Set to Hopping mode

Result:

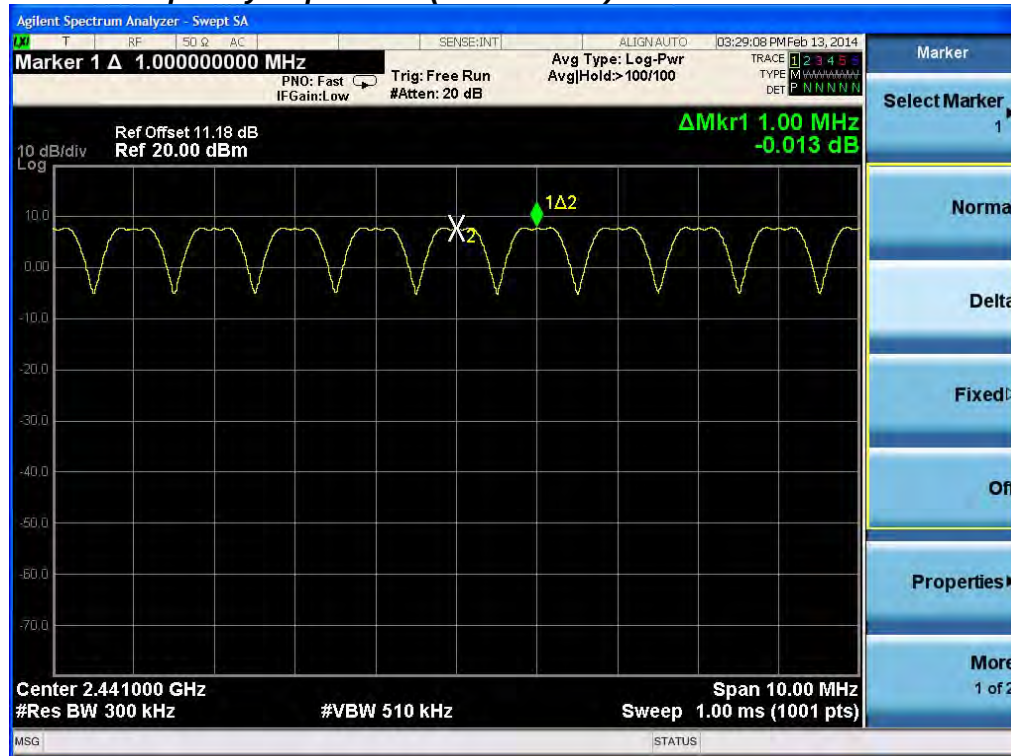
Modulation Mode	Carrier Frequency Separation (kHz)	Limit (2 / 3 of 20dB Bandwidth) (kHz)	Margin (kHz)
GFSK	1000	661.13	338.87
π /4DQPSK	1000	850.67	149.33
8DPSK	1000	842.67	157.33

Note:

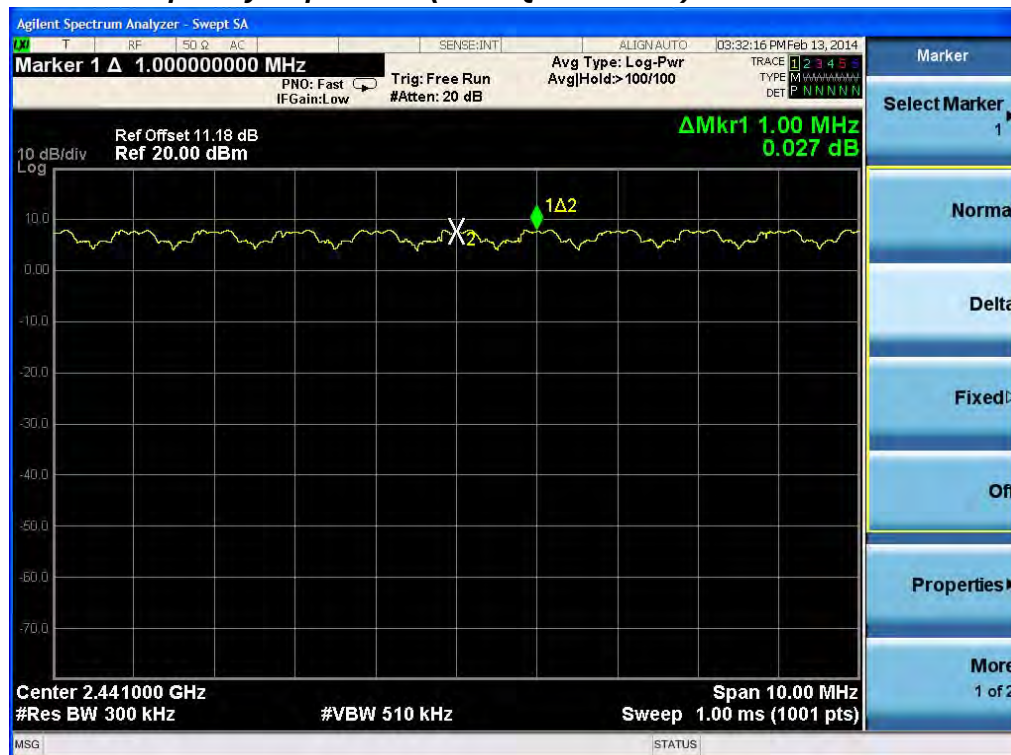
The EUT complies with the minimum channel separation requirement when it is operating 1x/EDR mode using 79 channels and when operating in AFH mode using 20 channels.

PLOTS OF EMISSIONS

Carrier Frequency Separation (GFSK Mode)

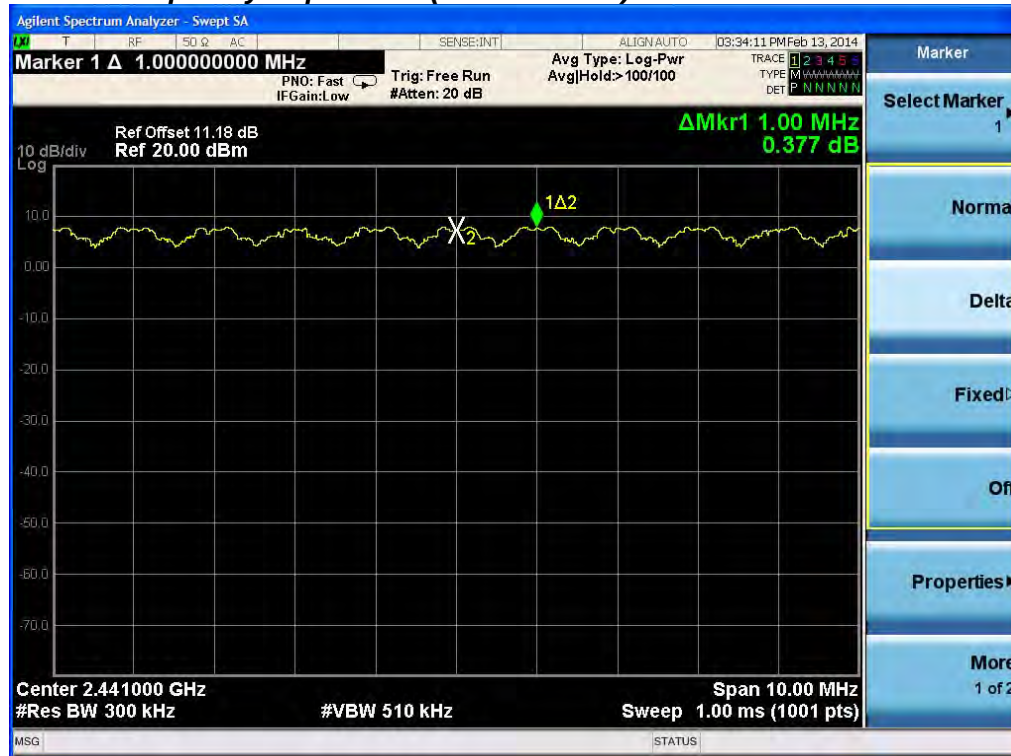


Carrier Frequency Separation ($\pi/4$ DQPSK Mode)



PLOTS OF EMISSIONS

Carrier Frequency Separation (8DPSK Mode)



TEST DATA

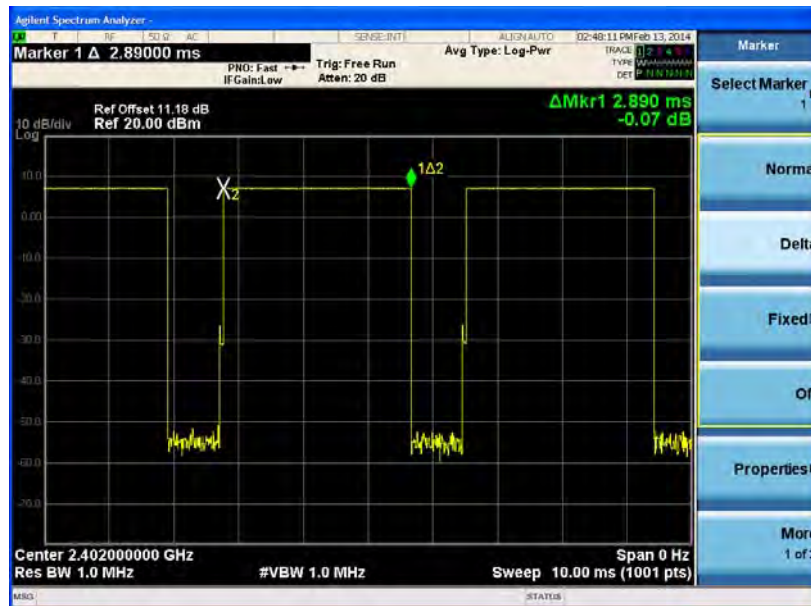
8.4 Transmitter Average Time of Occupancy

FCC §15.247(a)(1)(iii), IC RSS-210 A8.1(4)

Test mode : Set to Hopping mode

Result:

Mode	Pulse width (ms)	*)Numbers of slots	**) Average time of Occupancy(ms)	Limit (ms)	Margin (ms)
1x/EDR	2.89	106.7	308.4	≤ 400	91.6
AFH	2.89	53.3	154.0	≤ 400	246.0



1x/EDR mode

- 1) This result was measured at DH5 mode in **1x/EDR mode**, which has longest time in one transmission burst.
- 2) Bluetooth 1x/EDR mode has a channel hopping rate of 1600 hops/s and 79 hopping channels.
- 3) The average time of occupancy in the specified 31.6 second period (79 channels x 0.4 s) is equal to pulse width x (hopping rate / 6) / 79 x (0.4 x hopping channels).
- 4) *) Numbers of slots in 31.6 sec = (1600 / 6) / 79 x 31.6
- 5) **) Average time of Occupancy = 2.89 ms x 106.7 = 308.4 ms

AFH mode

- 1) This result was measured at DH5 mode in **AFH mode**, which has longest time in one transmission burst.
- 2) Bluetooth AFH mode has a channel hopping rate of 800 hops/s and 20 hopping channels.
- 3) The average time of occupancy in the specified 8 second period (20 channels x 0.4 s) is equal to pulse width x (hopping rate / 6) / 20 x (0.4 x hopping channels).
- 4) *) Numbers of slots in 20 sec = (800 / 6) / 20 x 8
- 5) **) Average time of Occupancy = 2.89 ms x 53.3 = 154.0 ms

TEST DATA

8.5 Number of Hopping Channels

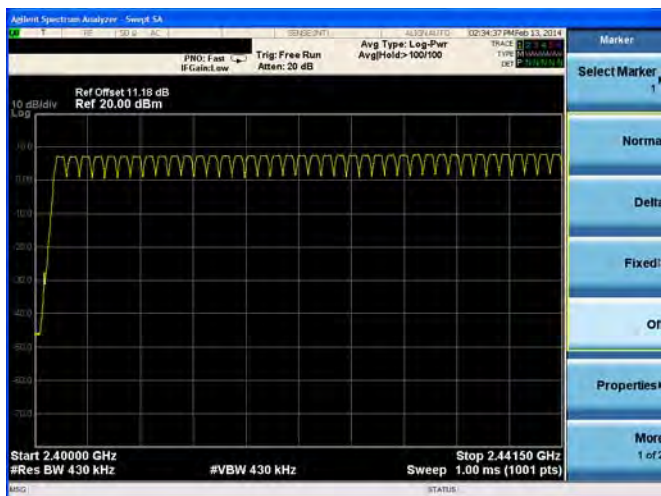
FCC §15.247(a)(1)(iii), IC RSS-210 A8.1(4)

Test mode : Set to Hopping mode

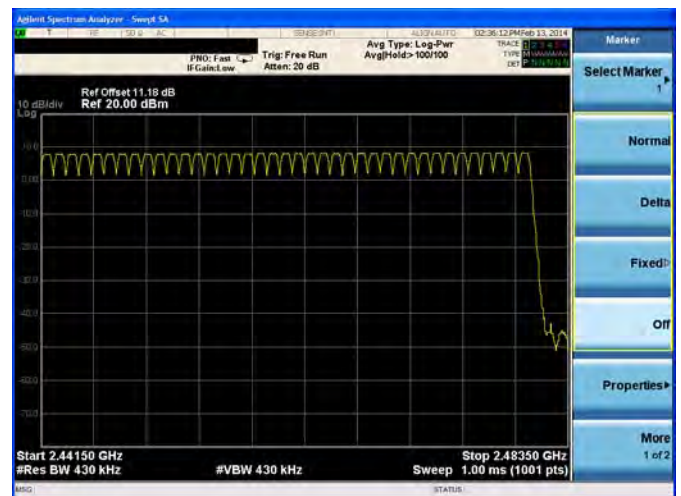
Result:

The EUT complies with the minimum number of hopping channels when it is operating **1x/EDR mode using 79 channels** and when operating in **AFH mode using 20 channels**.

Top half of Authorized band(1x mode)



Bottom half of Authorized band(1x mode)



TEST DATA

8.6 Peak Power Output

FCC §15.247(b)(1), IC RSS-210 A8.4(2)

Test Mode : Set to Lowest channel, Middle channel and Highest channel

Result:

Modulation	Frequency (MHz)	Peak Power (dBm)	Limit (dBm)	Margin (dB)
GFSK	2402	7.19	30.00	22.81
GFSK	2441	7.93	30.00	22.07
GFSK	2480	8.39	30.00	21.61
$\pi/4$ DQPSK	2402	8.05	30.00	21.95
$\pi/4$ DQPSK	2441	8.81	30.00	21.19
$\pi/4$ DQPSK	2480	9.21	30.00	20.79
8DPSK	2402	8.44	30.00	21.56
8DPSK	2441	9.19	30.00	20.81
8DPSK	2480	9.63	30.00	20.37

Note(s)

The following formula was used for spectrum offset:

Spectrum offset (dB) = Attenuator (dB) + Cable Loss (dB) + SMA Type Connector Loss (dB)

PLOT OF TEST DATA

Maximum Peak Output Power, Lowest channel (2402 MHz, GFSK mode)



Maximum Peak Output Power, Middle channel (2441 MHz, GFSK mode)



PLOT OF TEST DATA

Maximum Peak Output Power, Highest channel (2480 MHz, GFSK mode)



Maximum Peak Output Power, Lowest channel (2402 MHz, $\pi/4$ DQPSK)



PLOT OF TEST DATA

Maximum Peak Output Power, Middle channel (2441 MHz, $\pi/4$ DQPSK)



Maximum Peak Output Power, Highest channel (2480 MHz, $\pi/4$ DQPSK)



PLOT OF TEST DATA

Maximum Peak Output Power, Lowest channel (2402 MHz, 8DPSK)



Maximum Peak Output Power, Middle channel (2441 MHz, 8DPSK)



PLOT OF TEST DATA

Maximum Peak Output Power, Highest channel (2480 MHz, 8DPSK)



TEST DATA

8.7 Conducted Spurious Emission

FCC §15.247(d), IC RSS-210 A8.5

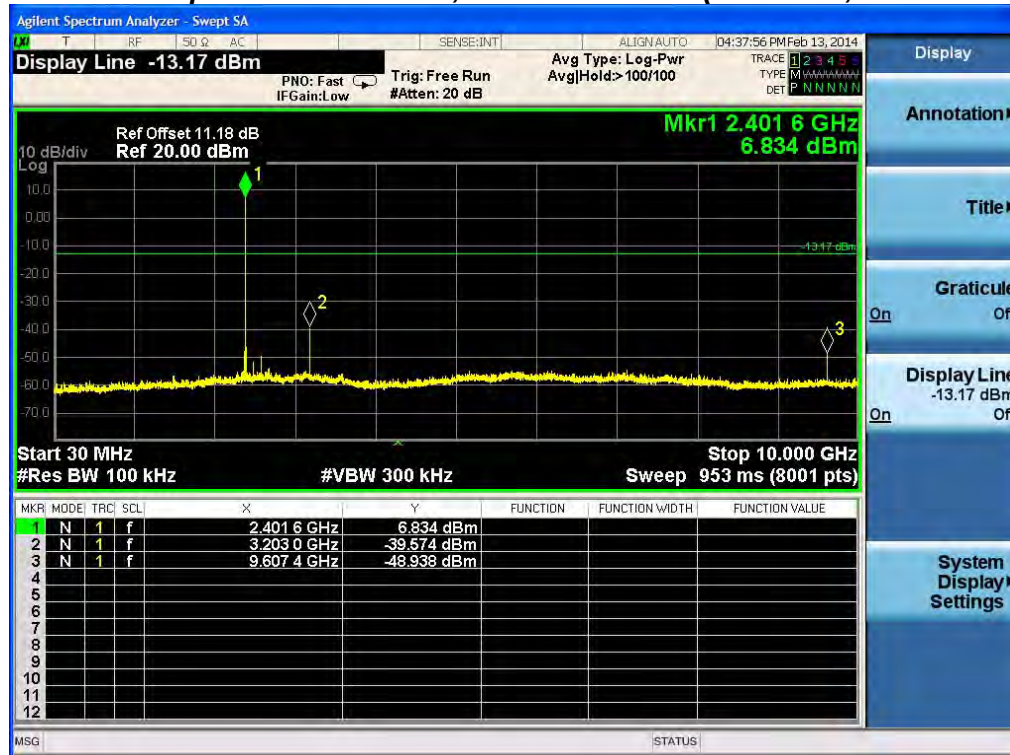
Test Mode : Set to Lowest channel, Middle channel and Highest channel

Result:

Modulation Mode	Frequency(MHz)	Result	Limit(dBc)
GFSK	2402	More than 20 dBc	20
GFSK	2441	More than 20 dBc	20
GFSK	2480	More than 20 dBc	20
$\pi/4$ DQPSK	2402	More than 20 dBc	20
$\pi/4$ DQPSK	2441	More than 20 dBc	20
$\pi/4$ DQPSK	2480	More than 20 dBc	20
8DPSK	2402	More than 20 dBc	20
8DPSK	2441	More than 20 dBc	20
8DPSK	2480	More than 20 dBc	20

PLOT OF TEST DATA

Conducted Spurious Emissions, 30 MHz ~ 10 GHz(2402 MHz, GFSK Mode)

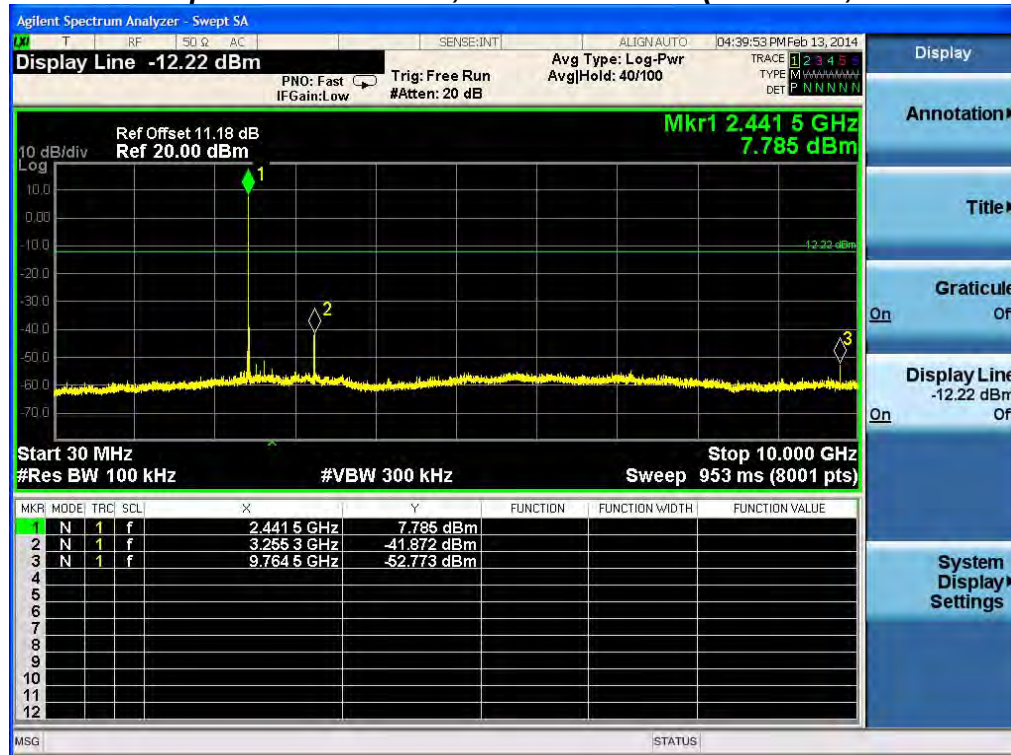


Conducted Spurious Emissions, 10 GHz ~ 25 GHz(2402 MHz, GFSK Mode)



PLOT OF TEST DATA

Conducted Spurious Emissions, 30 MHz ~ 10 GHz(2441 MHz, GFSK Mode)

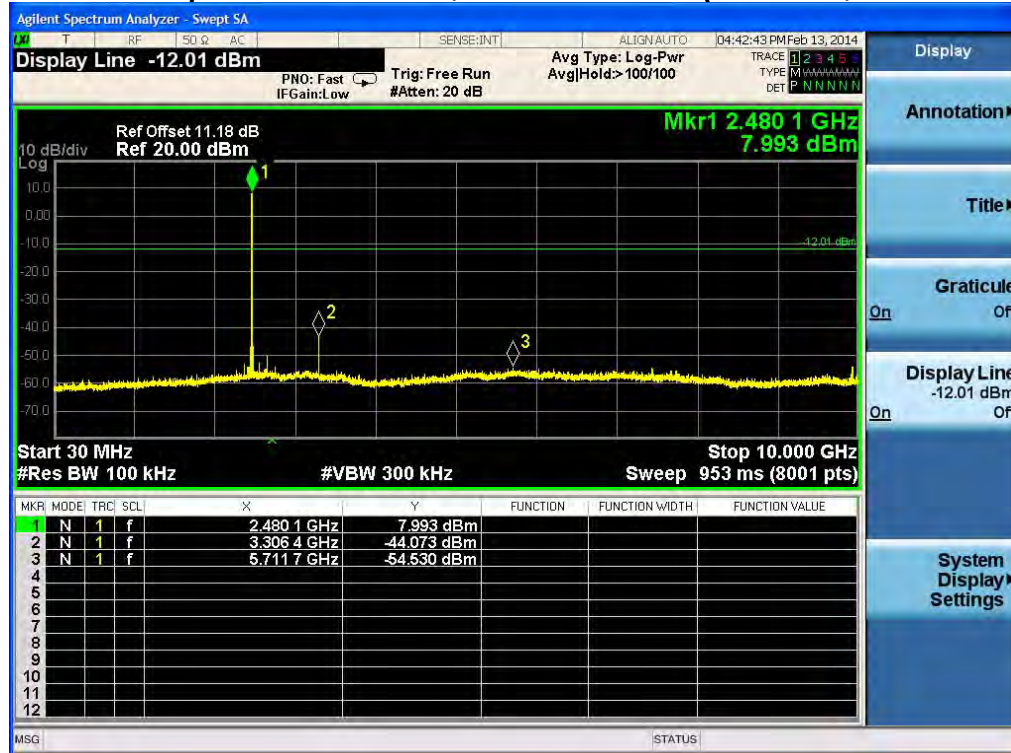


Conducted Spurious Emissions, 10 GHz ~ 25GHz(2441 MHz, GFSK Mode)



PLOT OF TEST DATA

Conducted Spurious Emissions, 30 MHz ~ 10 GHz(2480 MHz, GFSK Mode)

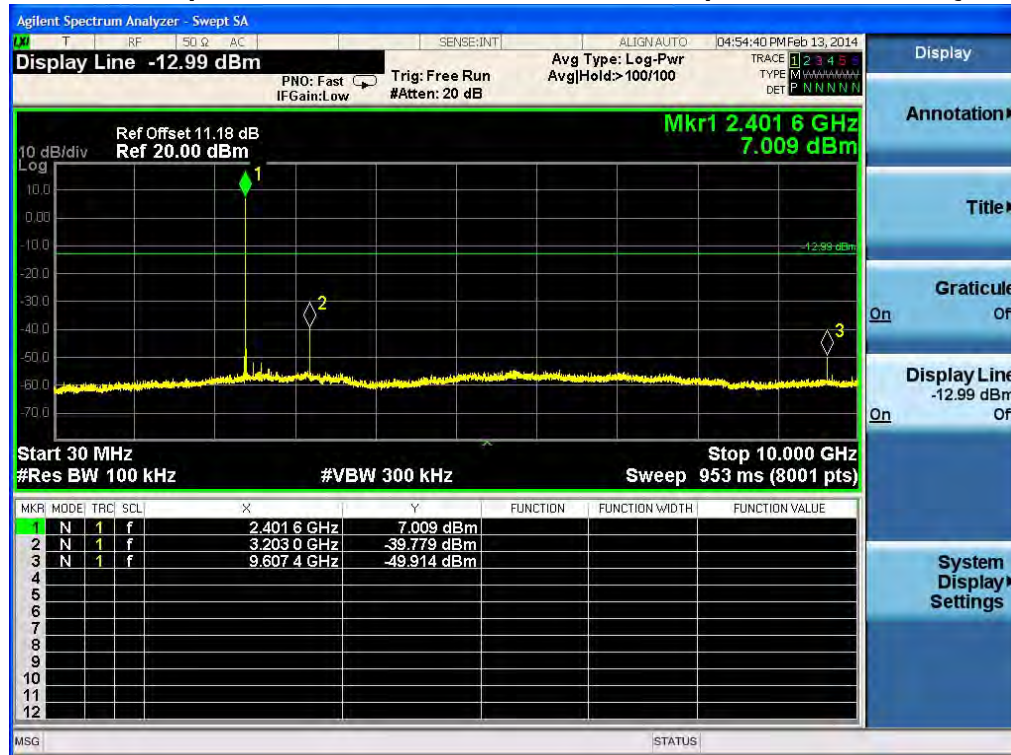


Conducted Spurious Emissions, 10 GHz ~ 25 GHz(2480 MHz, GFSK Mode)



PLOT OF TEST DATA

Conducted Spurious Emissions, 30 MHz ~ 10 GHz(2402 MHz, $\pi/4$ DQPSK Mode)

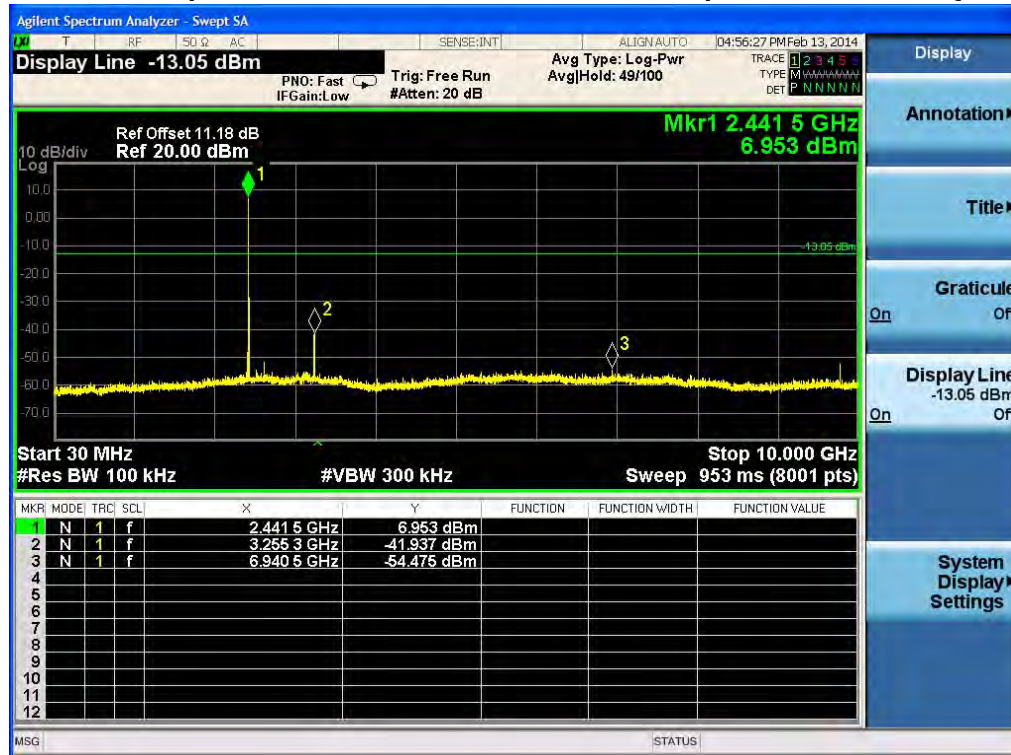


Conducted Spurious Emissions, 10 GHz ~ 25 GHz(2402 MHz, $\pi/4$ DQPSK Mode)



PLOT OF TEST DATA

Conducted Spurious Emissions, 30 MHz ~ 10 GHz(2441 MHz, $\pi/4$ DQPSK Mode)

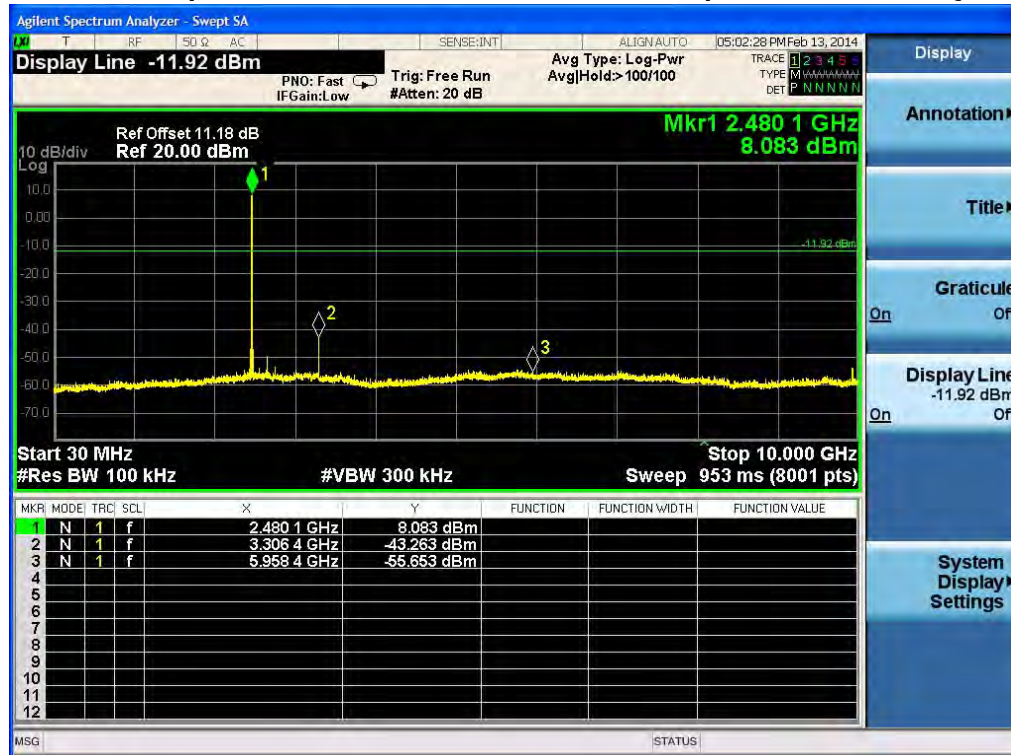


Conducted Spurious Emissions, 10 GHz ~ 25GHz(2441 MHz, $\pi/4$ DQPSK Mode)



PLOT OF TEST DATA

Conducted Spurious Emissions, 30 MHz ~ 10 GHz(2480 MHz, $\pi/4$ DQPSK Mode)

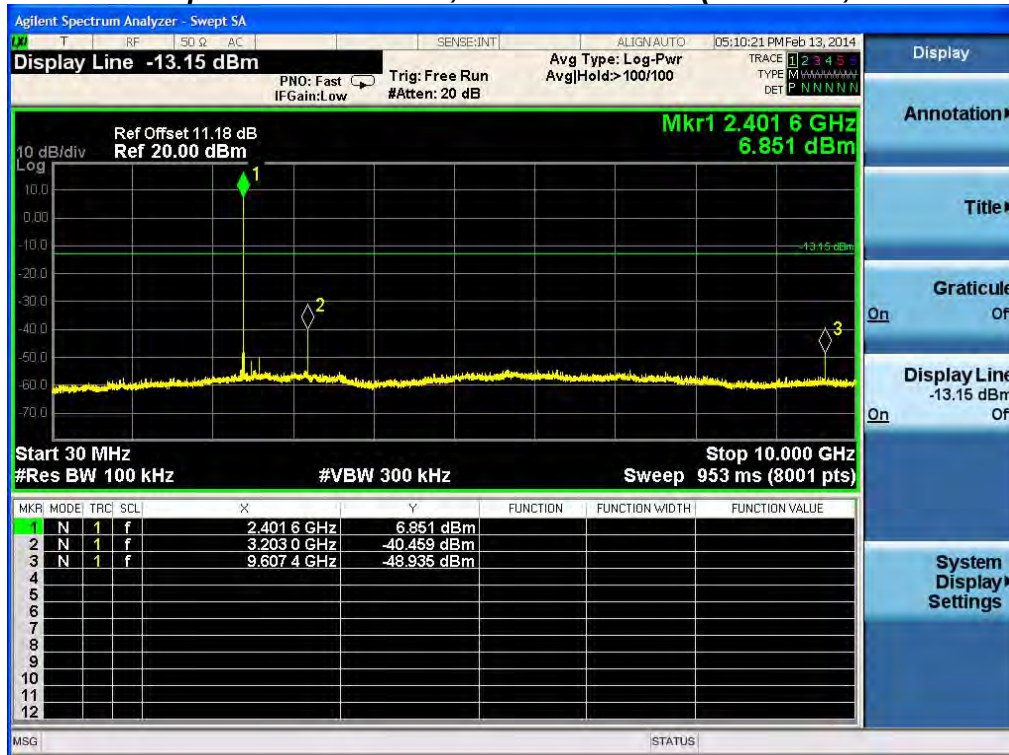


Conducted Spurious Emissions, 10 GHz ~ 25 GHz(2480 MHz, $\pi/4$ DQPSK Mode)



PLOT OF TEST DATA

Conducted Spurious Emissions, 30 MHz ~ 10 GHz(2402 MHz, 8DPSK Mode)

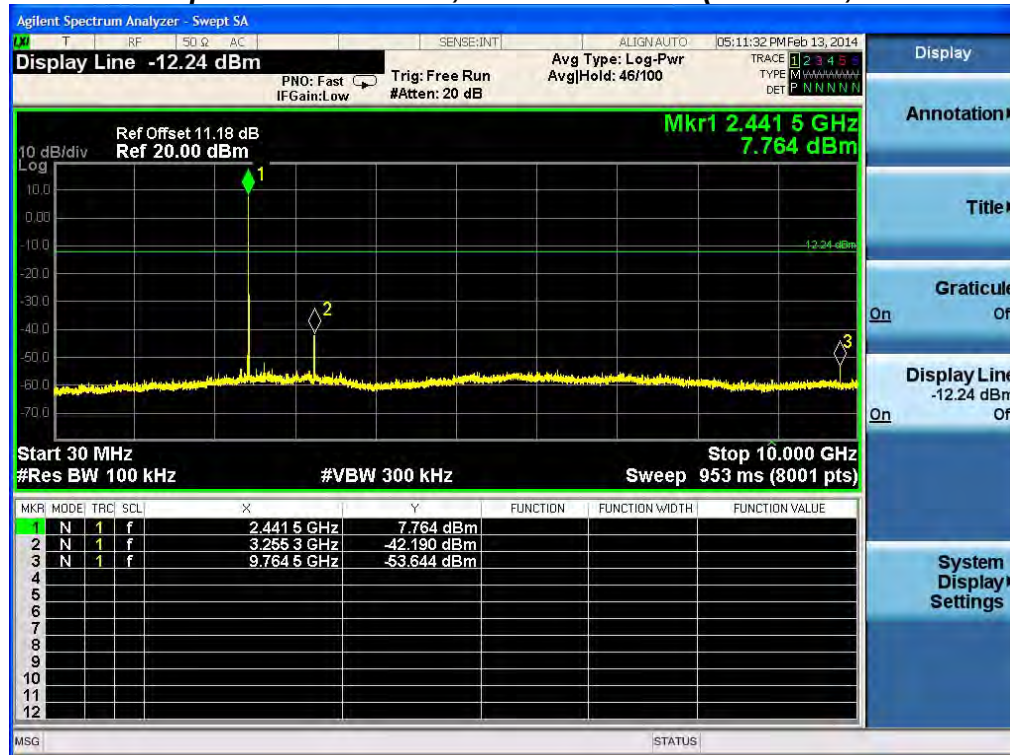


Conducted Spurious Emissions, 10 GHz ~ 25 GHz(2402 MHz, 8DPSK Mode)



PLOT OF TEST DATA

Conducted Spurious Emissions, 30 MHz ~ 10 GHz(2441 MHz, 8DPSK Mode)

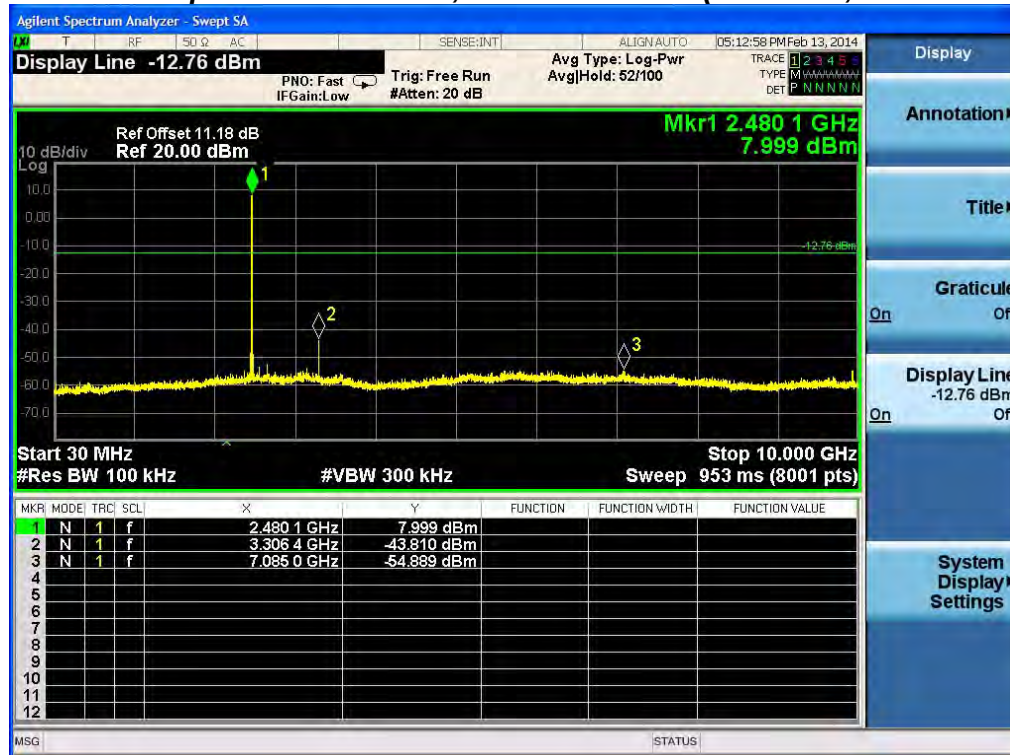


Conducted Spurious Emissions, 10 GHz ~ 25GHz(2441 MHz, 8DPSK Mode)



PLOT OF TEST DATA

Conducted Spurious Emissions, 30 MHz ~ 10 GHz(2480 MHz, 8DPSK Mode)

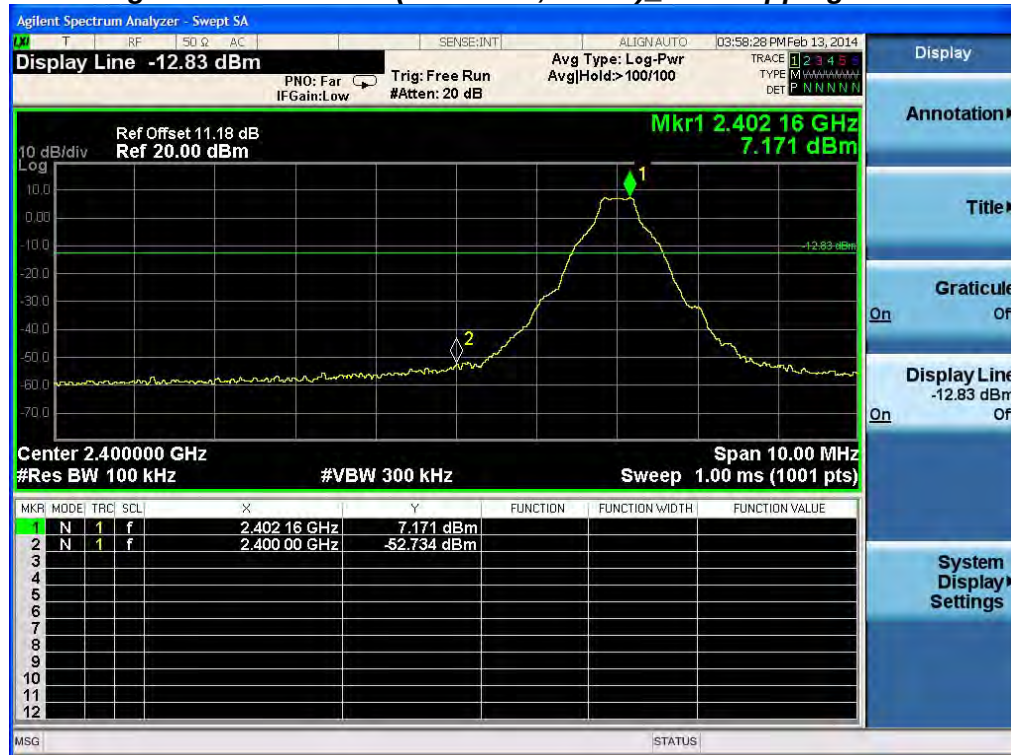


Conducted Spurious Emissions, 10 GHz ~ 25 GHz(2480 MHz, 8DPSK Mode)



PLOT OF TEST DATA

Band Edge Lowest Channel(2402 MHz, GFSK) Non-hopping mode



Band Edge Lowest Channel(2402 MHz, GFSK) Hopping mode



PLOT OF TEST DATA

Band Edge Highest Channel(2480 MHz, GFSK)_Non-hopping mode



Band Edge Highest Channel(2480 MHz, GFSK)_Hopping mode



PLOT OF TEST DATA

Band Edge Lowest Channel(2402 MHz, $\pi/4$ DQPSK Mode) Non-hopping mode



Band Edge Lowest Channel(2402 MHz, $\pi/4$ DQPSK Mode) Hopping mode



PLOT OF TEST DATA

Band Edge Highest Channel(2480 MHz, $\pi/4$ DQPSK Mode)_Non-hopping mode

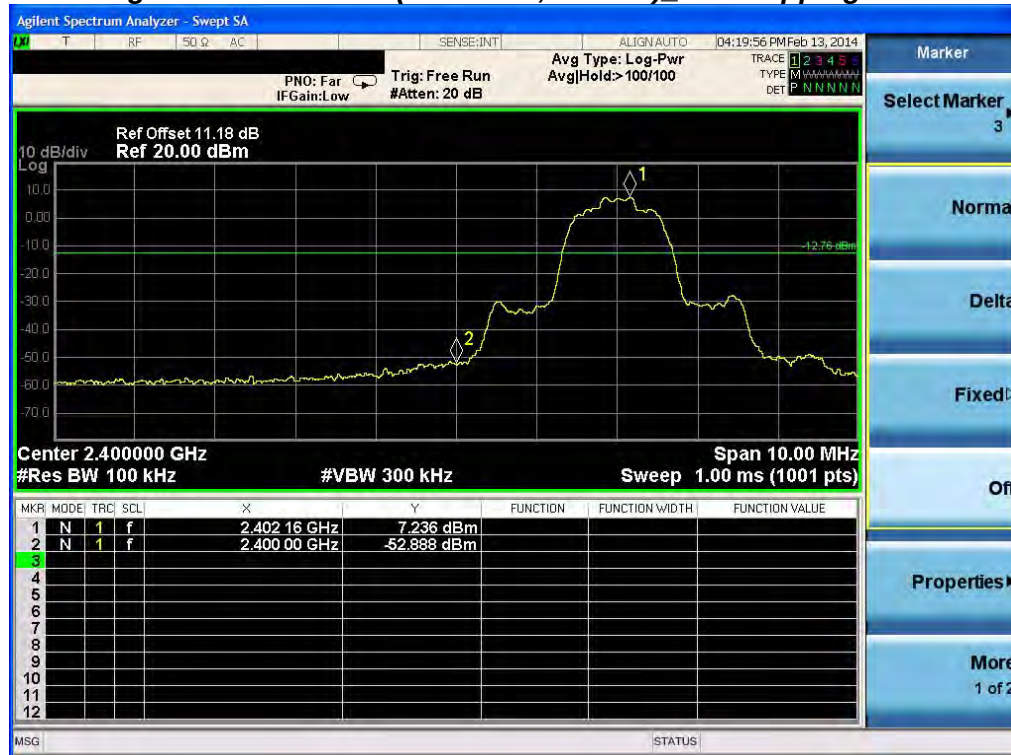


Band Edge Highest Channel(2480 MHz, $\pi/4$ DQPSK Mode)_Hopping mode



PLOT OF TEST DATA

Band Edge Lowest Channel(2402 MHz, 8DPSK)_Non-hopping mode



Band Edge Lowest Channel(2402 MHz, 8DPSK)_Hopping mode



PLOT OF TEST DATA

Band Edge Highest Channel(2480 MHz, 8DPSK) Non-hopping mode



Band Edge Highest Channel(2480 MHz, 8DPSK) Hopping mode



TEST DATA

8.8 Radiated Spurious Emission

FCC §15.247(d), IC RSS-210 A8.5

Test Mode : Set to Lowest channel, Middle channel and Highest channel

Result:

Lowest Channel

Frequency (MHz)	Reading (dBμV)	Pol* (H/V)	mode	AF+CL+Amp (dB)**	Duty Cycle Correction (dB)***	Result (dBμV/m)	Limit (dBμV/m)	Margin (dB)
2330.00	31.4	V	peak	-1.0	0.0	30.4	74.0	43.6
2330.00	22.5	V	average	-1.0	0.0	21.5	54.0	32.5
2338.00	32.2	V	peak	-1.0	0.0	31.2	74.0	42.8
2338.00	22.3	V	average	-1.0	0.0	21.3	54.0	32.7
2354.25	30.6	V	peak	-0.9	0.0	29.7	74.0	44.3
2354.25	19.4	V	average	-0.9	0.0	18.5	54.0	35.5
2370.00	29.9	V	peak	-0.9	0.0	29.0	74.0	45.0
2370.00	17.5	V	average	-0.9	0.0	16.6	54.0	37.4
2378.00	31.1	V	peak	-0.8	0.0	30.3	74.0	43.7
2378.00	19.6	V	average	-0.8	0.0	18.8	54.0	35.2
4804.06	51.0	H	peak	9.4	0.0	60.4	75.0	14.6
4804.06	47.0	H	average	9.4	-22.5	33.9	54.0	20.1

TEST DATA

Middle Channel

Frequency (MHz)	Reading (dBμV)	Pol* (H/V)	mode	AF+CL+Amp (dB)**	Duty Cycle Correction (dB)***	Result (dBμV/m)	Limit (dBμV/m)	Margin (dB)
2345.00	45.5	V	peak	-1.0	0.0	44.5	74.0	29.5
2345.00	36.9	V	average	-1.0	0.0	35.9	54.0	18.1
2369.00	43.5	V	peak	-1.0	0.0	42.5	74.0	31.5
2369.00	33.7	V	average	-1.0	0.0	32.7	54.0	21.3
2377.00	43.6	V	peak	-0.9	0.0	42.7	74.0	31.3
2377.00	34.1	V	average	-0.9	0.0	33.2	54.0	20.8
4606.88	52.6	H	peak	-0.9	0.0	51.7	74.0	22.3
4606.88	39.8	H	average	-0.9	0.0	38.9	54.0	15.1
4882.04	49.4	H	peak	9.7	0.0	59.1	74.0	14.9
4882.04	45.0	H	average	9.7	-22.5	32.2	54.0	21.8
5203.75	41.4	H	peak	10.3	0.0	51.7	74.0	22.3
5203.75	30.6	H	average	10.3	0.0	40.9	54.0	13.1

TEST DATA

Highest Channel

Frequency (MHz)	Reading (dBμV)	Pol* (H/V)	mode	AF+CL+Amp (dB)**	Duty Cycle Correction (dB)***	Result (dBμV/m)	Limit (dBμV/m)	Margin (dB)
2288.00	43.7	V	peak	-1.2	0.0	42.5	74.0	31.5
2288.00	34.5	V	average	-1.2	0.0	33.3	54.0	20.7
2336.00	43.7	V	peak	-1.0	0.0	42.7	74.0	31.3
2336.00	33.7	V	average	-1.0	0.0	32.7	54.0	21.3
2360.25	43.9	V	peak	-0.9	0.0	43.0	74.0	31.0
2360.25	33.6	V	average	-0.9	0.0	32.7	54.0	21.3
2384.00	45.7	V	peak	-0.8	0.0	44.9	74.0	29.1
2384.00	37.3	V	average	-0.8	0.0	36.5	54.0	17.5
3856.25	43.8	V	peak	6.3	0.0	50.1	74.0	23.9
3856.25	31.1	V	average	6.3	0.0	37.4	54.0	16.6
4960.01	49.9	V	peak	9.9	0.0	59.8	74.0	14.2
4960.01	45.4	V	average	9.9	-22.5	32.8	54.0	21.2

Notes:

- *Pol. H = Horizontal V = Vertical
- **AF + CL + Amp. = Antenna Factor + Cable Loss + Amplifier.
- *** Duty Cycle Correction Factor Calculation (AFH mode):
 - Channel hop rate = 800 hops/second
 - Adjusted channel hop rate for DH5 mode = 133.33 hops/second
 - Time per channel hop = $1/133.33$ hops/second = 7.50 ms
 - Time to cycle through all channels = 7.50 x 20 channels = 150 ms
 - Number of times transmitter hits on one channel = 100 ms / 150 ms = 1 time(s)
 - Worst case dwell time = 7.50 ms
 - Duty cycle correction factor = $20\log_{10}(7.50\text{ms}/100\text{ms}) = -22.5$ dB
- Other spurious was under 20 dB below Fundamental.
- GFSK modulation was the worst condition.
- The radiated emissions testing were made by rotating EUT through three orthogonal axes and rotating the receive antenna with horizontal, Vertical polarization. The worst data was recorded.
- Peak emissions were measured using RBW = 1 MHz, VBW = 1 MHz, Detector = Peak.
- Average emissions were measured using RBW = 1MHz, VBW = 1 kHz ($> 1/\tau$ Hz, where τ is pulse width on second), Detector = Peak.
- The spectrum was measured from 9 kHz to 10th harmonic and the worst-case emissions were reported. No significant emissions were found beyond the second harmonic for this device.

TEST DATA

8.9 Radiated Restricted Band Edge

FCC §15.247(d), IC RSS-210 A8.5

Test Mode : Set to Lowest channel, Highest channel

Lowest Channel

Frequency (MHz)	Reading (dBμV)	Pol* (H/V)	mode	AF+CL+Amp (dB)**	Duty Cycle Correction (dB)***	Result (dBμV/m)	Limit (dBμV/m)	Margin (dB)
2390.00	50.1	V	peak	-0.8	0.0	49.3	74.0	24.7
2390.00	47.3	V	average	-0.8	0.0	46.5	54.0	7.5

Highest Channel

Frequency (MHz)	Reading (dBμV)	Pol* (H/V)	mode	AF+CL+Amp (dB)**	Duty Cycle Correction (dB)***	Result (dBμV/m)	Limit (dBμV/m)	Margin (dB)
2483.50	59.6	V	peak	-0.3	0.0	59.3	74.0	14.7
2483.50	57.1	V	average	-0.3	-22.5	34.3	54.0	19.7

Notes:

- *Pol. H = Horizontal V = Vertical
- **AF + CL + Amp. = Antenna Factor + Cable Loss + Amplifier.
- *** Duty Cycle Correction Factor Calculation (AFH mode):
 - Channel hop rate = 800 hops/second
 - Adjusted channel hop rate for DH5 mode = 133.33 hops/second
 - Time per channel hop = 1/133.33 hops/second = 7.50 ms
 - Time to cycle through all channels = 7.50 x 20 channels = 150 ms
 - Number of times transmitter hits on one channel = 100 ms / 150 ms = 1 time(s)
 - Worst case dwell time = 7.50 ms
 - Duty cycle correction factor = $20\log_{10}(7.50\text{ms}/100\text{ms}) = -22.5 \text{ dB}$
- GFSK modulation mode was the worst condition.
- The radiated emissions testing were made by rotating EUT through three orthogonal axes and rotating

the receive antenna with horizontal, Vertical polarization. The worst data was recorded.

- 6. Peak emissions were measured using RBW = 1 MHz, VBW = 1 MHz, Detector = Peak.*
- 7. Average emissions were measured using RBW = 1 MHz, VBW = 1 kHz ($> 1/\tau$ Hz, where τ is pulse width on second), Detector = Peak.*

9. TEST EQUIPMENT

No.	Instrument	Manufacturer	Model	Serial No.	Calibration Date	Calibration Interval
1	*Test Receiver	R & S	ESU 40	100202	Apr. 04 2013	1 year
2	Test Receiver	R & S	ESCS 30	100302	Oct. 08 2013	1 year
3	*Amplifier	R & S	SCU 01	10030	Apr. 04 2013	1 year
4	*Amplifier	Sonoma Instrument	310N	291916	Jul. 16 2013	1 year
5	*Amplifier	R & S	SCU18	10065	Apr. 05 2013	1 year
6	*Amplifier	R & S	SCU26	10011	Jul. 08 2013	1 year
7	Amplifier	R & S	SCU40	10008	Jul. 08 2013	1 year
8	*Pre Amplifier	HP	8449B	3008A00107	Jan. 09 2014	1 year
9	Spectrum Analyzer	Agilent	E4440A	MY44303257	Jul. 16 2013	1 year
10	*Spectrum Analyzer	Agilent	N9020A	MY51110087	Jul. 17 2013	1 year
11	*Attenuator	R & S	FSP40	100361	Apr. 04 2013	1 year
12	*Loop Antenna	R & S	HFH2-Z2	100279	Feb. 13 2014	2 year
13	Wideband Power Sensor	R & S	NRP-Z81	100634	Jul. 16 2013	1 year
14	*Biconical Log Antenna	ARA	LPB-2520/A	1180	Apr. 26 2012	2 year
15	*Horn Antenna	SCHWARZBECK	BBHA9120D	9120D-474	Aug. 13 2012	2 year
16	*Horn Antenna	Q-par Angus	QSH20S20	8179	Mar. 20 2013	2 year
17	Horn Antenna	Q-par Angus	QSH22K20	8180	Mar. 20 2013	2 year
18	*Trilog-Broadband Antenna	SCHWARZBECK	VULB 9163	9163-423	Jun. 21 2013	2 year
19	Trilog-Broadband Antenna	SCHWARZBECK	VULB 9168	9168-257	Mar. 06 2013	2 year
20	LISN	R & S	ESH3-Z5	833874/006	Oct. 08 2013	1 year
21	*Controller	INNCO	CO2000-G	CO2000/562/23890210/L	N/A	N/A
22	*Open Switch And Control Unit	R & S	OSP-120	100015	N/A	N/A
23	*Turn Table	INNCO	DT3000-3T	N/A	N/A	N/A
24	*Antenna Mast	INNCO	MA4000-EP	N/A	N/A	N/A
25	*Anechoic Chamber	SY Corporation	N/A	N/A	N/A	N/A
26	*Position Controller	INNCO	CO2000	1480406/L	N/A	N/A
27	*Turn Table	INNCO	DS1200S	N/A	N/A	N/A
28	*Antenna Mast	INNCO	MA4000	N/A	N/A	N/A
29	*Anechoic Chamber	Seo-Young EMC	N/A	N/A	N/A	N/A
30	*Shielded Room	Seo-Young EMC	N/A	N/A	N/A	N/A

Note(s)

* Test equipment used during the test.

10. ACCURACY OF MEASUREMENT

The Measurement Uncertainties stated were calculated in accordance with the requirements of measurement uncertainty contained in CISPR 16-4-2 with the confidence level of 95%

1. Conducted Uncertainty Calculation

Source of Uncertainty	X_i	Uncertainty of X_i		Coverage factor k	$u(X_i)$ (dB)	C_i	$C_i u(X_i)$ (dB)
		Value (dB)	Probability Distribution				
Receiver reading	RI	± 0.1	normal 1	1.000	0.1	1	0.1
Attenuation AMN-Receiver	LC	± 0.08	normal 2	2.000	0.04	1	0.04
AMN Voltage division factor	LAMN	± 0.8	normal 2	2.000	0.4	1	0.4
Sine wave voltage	dVSW	± 2.00	normal 2	2.000	1.00	1	1.00
Pulse amplitude response	dVPA	± 1.50	rectangular	1.732	0.87	1	0.87
Pulse repetition rate response	dVPR	± 1.50	rectangular	1.732	0.87	1	0.87
Noise floor proximity	dVNF	± 0.00	-	-	0.00	1	0.00
AMN Impedance	dZ	± 1.80	triangular	2.449	0.73	1	0.73
Ⓐ Mismatch	M	+ 0.70	U-Shaped	1.414	0.49	1	0.49
Ⓑ Mismatch	M	- 0.80	U-Shaped	1.414	- 0.56	1	- 0.56
Measurement System Repeatability	RS	0.05	normal 1	1.000	0.05	1	0.05
Remark	Ⓐ: AMN-Receiver Mismatch : + Ⓑ: AMN-Receiver Mismatch : -						
Combined Standard Uncertainty	Normal			± 1.88			
Expended Uncertainty U	Normal ($k = 2$)			± 3.76			

2. Radiation Uncertainty Calculation

Source of Uncertainty	X_i	Uncertainty of X_i		Coverage factor k	$u(X_i)$ (dB)	C_i	$C_i u(X_i)$ (dB)
		Value (dB)	Probability Distribution				
Receiver reading	RI	± 0.10	normal 1	1.000	0.10	1	0.10
Sine wave voltage	dVsw	± 2.00	normal 2	2.000	1.00	1	1.00
Pulse amplitude response	dVpa	± 1.50	rectangular	1.732	0.87	1	0.87
Pulse repetition rate response	dVpr	± 1.50	rectangular	1.732	0.87	1	0.87
Noise floor proximity	dVnf	± 0.50	normal 2	2.000	0.25	1	0.25
Antenna Factor Calibration	AF	± 1.50	normal 2	2.000	0.75	1	0.75
Attenuation Antenna-receiver	CL	± 0.52	normal 2	2.000	0.26	1	0.26
Antenna Directivity	AD	± 1.00	rectangular	1.732	0.58	1	0.58
Antenna Factor Height Dependence	AH	± 0.50	rectangular	1.732	0.29	1	0.29
Antenna Phase Centre Variation	AP	± 0.30	rectangular	1.732	0.17	1	0.17
Antenna Factor Frequency Interpolation	AI	± 0.30	rectangular	1.732	0.17	1	0.17
Site Imperfections	SI	± 4.00	triangular	2.449	1.63	1	1.63
Measurement Distance Variation	DV	± 0.10	rectangular	1.732	0.06	1	0.06
Antenna Balance	DbaI	± 0.90	rectangular	1.732	0.52	1	0.52
Cross Polarisation	DCross	± 0.90	rectangular	1.732	0.52	1	0.52
Ⓐ Mismatch	M	+ 0.25	U-Shaped	1.414	0.18	1	0.18
Ⓑ Mismatch	M	- 0.26	U-Shaped	1.414	- 0.18	1	- 0.18
Ⓒ Mismatch	M	+ 0.98	U-Shaped	1.414	0.69	1	0.69
Ⓓ Mismatch	M	- 1.11	U-Shaped	1.414	- 0.79	1	- 0.79
Measurement System Repeatability	RS	0.09	normal 1	1.000	0.09	1	0.09
Remark	Ⓐ: Biconical Antenna-receiver Mismatch : + (< 200 MHz) Ⓑ: Biconical Antenna-receiver Mismatch : - (< 200 MHz) Ⓒ: Log Periodic Antenna-receiver Mismatch : + ($\geq$ 200 MHz) Ⓓ: Log Periodic Antenna-receiver Mismatch : - ($\geq$ 200 MHz)						
Combined Standard Uncertainty	Normal			± 2.63 (< 200 MHz) ± 2.74 ($\geq$ 200 MHz)			
Expanded Uncertainty U	Normal ($k = 2$)			± 5.26 (< 200 MHz) ± 5.48 ($\geq$ 200 MHz)			